

### SKiM<sup>®</sup> 93

### Trench IGBT Modules

#### SKiM429GD17E4HD

#### Features

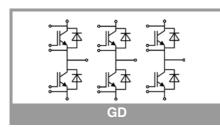
- IGBT 4 Trench Gate Technology
- Solderless sinter technology
- V<sub>CE(sat)</sub> with positive temperature coefficient
- Low inductance case
- Insulated by Al<sub>2</sub>O<sub>3</sub> DBC (Direct Bonded Copper) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to 6 x  $I_C$
- Integrated temperature sensor

#### **Typical Applications\***

- Automotive inverter
- High reliability AC inverter wind
- High reliability AC inverter drives

### Remarks

- Case temperature limited to T<sub>s</sub> = 125°C max; T<sub>c</sub> = T<sub>s</sub> (for baseplateless modules)
- Recommended  $T_{op} = -40 \dots + 125^{\circ}C$  for Inverse Diode,  $T_{op} = -40 \dots + 150^{\circ}C$  for IGBT



Maximum Ratings	5			
Conditions		Value	Values	
IGBT				
T <sub>i</sub> = 25 °C		1700	1700	
λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	595		Α
T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	479		А
λ <sub>paste</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	789		А
T <sub>j</sub> = 175 °C	T <sub>s</sub> = 70 °C	639	639	
		420		А
$I_{CBM} = 3 \times I_{Cnom}$		1260	1260	
		-20 20		V
$V_{CC} = 1000 V$ $V_{GE} \le 15 V$ $V_{CES} \le 1700 V$	T <sub>j</sub> = 150 °C	10		μs
		-40	175	°C
Diode				
λ <sub>paste</sub> =0.8 W/(mK)	T <sub>s</sub> = 25 °C	411	411	
$T_{i} = 150 \text{ °C}$	T <sub>s</sub> = 70 °C	300	300	
λ <sub>pasta</sub> =2.5 W/(mK)	T <sub>s</sub> = 25 °C	503	503	
T <sub>j</sub> = 150 °C	T <sub>s</sub> = 70 °C	371		Α
		450		Α
I <sub>FBM</sub> = 2 x I <sub>Fnom</sub>		900		Α
t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 150 °C		2889		Α
		-40 '	-40 150	
T <sub>terminal</sub> = 80 °C,		700	700	
		-40 125		°C
AC sinus 50 Hz, t = 1 min		3000		V
eristics				
Conditions		min. typ	. max.	Unit
IGBT				
	$\begin{tabular}{ c c c c } \hline IGBT & \\ \hline T_{j} = 25 \ ^{\circ}C & \\ \hline \lambda_{paste} = 0.8 \ W/(mK) & \\ \hline T_{j} = 175 \ ^{\circ}C & \\ \hline \lambda_{paste} = 2.5 \ W/(mK) & \\ \hline T_{j} = 175 \ ^{\circ}C & \\ \hline I_{CRM} = 3 \ x \ I_{Cnom} & \\ \hline V_{CC} = 1000 \ V & \\ \hline V_{GE} \le 15 \ V & \\ V_{CES} \le 1700 \ V & \\ \hline \hline Diode & \\ \hline \lambda_{paste} = 0.8 \ W/(mK) & \\ \hline T_{j} = 150 \ ^{\circ}C & \\ \hline \lambda_{paste} = 2.5 \ W/(mK) & \\ \hline T_{j} = 150 \ ^{\circ}C & \\ \hline \lambda_{paste} = 2.5 \ W/(mK) & \\ \hline T_{j} = 150 \ ^{\circ}C & \\ \hline \mu_{FRM} = 2 \ x \ I_{Fnom} & \\ \hline t_{p} = 10 \ ms, \sin 180^{\circ} & \\ \hline \hline T_{terminal} = 80 \ ^{\circ}C, & \\ \hline AC \ sinus \ 50 \ Hz, t = \\ \hline \hline eristics & \\ \hline Conditions & \\ \hline \end{tabular}$	$\begin{tabular}{ c c c } \hline IGBT & & & & & & & & & & & & & & & & & & &$	IGBT T_j = 25 °C 1700 $\lambda_{paste}=0.8 \text{ W/(mK)}$ T_s = 25 °C 595   T_j = 175 °C T_s = 70 °C 479 $\lambda_{paste}=2.5 \text{ W/(mK)}$ T_s = 25 °C 789   T_j = 175 °C T_s = 70 °C 639 $V_{j} = 175 °C$ T_s = 70 °C 639   V_cc = 1000 V T_s = 70 °C 639   V_{CC} = 1000 V V_{QE} ≤ 15 V T_j = 150 °C 10   V_{CES} ≤ 1700 V T_j = 150 °C 10   Over the second se	IGBT   T <sub>j</sub> = 25 °C 1700 $\lambda_{paste}=0.8 W/(mK)$ T <sub>s</sub> = 25 °C 595   T <sub>j</sub> = 175 °C T <sub>s</sub> = 70 °C 479 $\lambda_{paste}=2.5 W/(mK)$ T <sub>s</sub> = 25 °C 789   T <sub>j</sub> = 175 °C T <sub>s</sub> = 70 °C 639 $\lambda_{paste}=2.5 W/(mK)$ T <sub>s</sub> = 70 °C 639   ICRM = 3 × I <sub>Cnom</sub> 1260   V <sub>CC</sub> = 1000 V V <sub>CE</sub> ≤ 15 V T <sub>j</sub> = 150 °C   V <sub>CE</sub> ≤ 1700 V T <sub>j</sub> = 150 °C 10   V <sub>CES</sub> ≤ 1700 V T <sub>j</sub> = 150 °C 10   V <sub>CES</sub> ≤ 1700 V T <sub>s</sub> = 70 °C 300 $\lambda_{paste}=0.8 W/(mK)$ T <sub>s</sub> = 25 °C 411   T <sub>j</sub> = 150 °C T <sub>s</sub> = 70 °C 300 $\lambda_{paste}=2.5 W/(mK)$ T <sub>s</sub> = 25 °C 503   T <sub>j</sub> = 150 °C T <sub>s</sub> = 70 °C 300 $\lambda_{paste}=2.5 W/(mK)$ T <sub>s</sub> = 25 °C 503   T <sub>j</sub> = 150 °C T <sub>s</sub> = 70 °C 300 $\lambda_{paste}=2.5 W/(mK)$ T <sub>s</sub> = 70 °C 2889   I=10 ms, sin 180°, T <sub>j</sub> = 150 °C 2889 -40 125   AC sinus 50 Hz, t = 1 min 3000 -40 125   AC

Inverter	- IGBT					
V <sub>CE(sat)</sub>	I <sub>C</sub> = 420 A	T <sub>j</sub> = 25 °C		1.90	2.25	V
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.10	2.30	V
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.10	1.20	V
		T <sub>j</sub> = 150 °C		1.00	1.10	V
· •	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C		1.90	2.5	mΩ
	chiplevel	T <sub>j</sub> = 150 °C		2.6	2.9	mΩ
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}, I_C = 16.8 \text{ mA}$		5.2	5.8	6.4	V
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = 17$	00 V, T <sub>j</sub> = 25 °C		0.15	0.5	mA
Cies	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		33		nF
C <sub>oes</sub>		f = 1 MHz	1.38			nF
C <sub>res</sub>		f = 1 MHz		1.08		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V+ 15 V T <sub>j</sub> = 25 °C			6660		nC
R <sub>Gint</sub>			2.7			Ω
t <sub>d(on)</sub>	1 100 1	T <sub>j</sub> = 125 °C		390		ns
t <sub>r</sub>		T <sub>j</sub> = 125 °C		80		
Eon		T <sub>j</sub> = 125 °C		245		
t <sub>d(off)</sub>		T <sub>j</sub> = 125 °C	1005			ns
t <sub>f</sub>			170			ns
E <sub>off</sub>	V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 125 °C		180		mJ
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =0.8 W/(mK)		0.079			K/W
R <sub>th(j-s)</sub>	per IGBT, λ <sub>paste</sub> =2.5 W/(mK)		0.051			K/W



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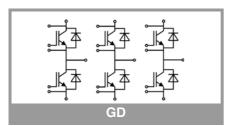
#### **Typical Applications\***

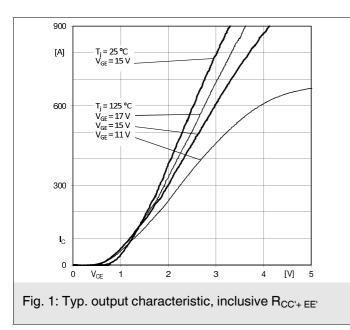
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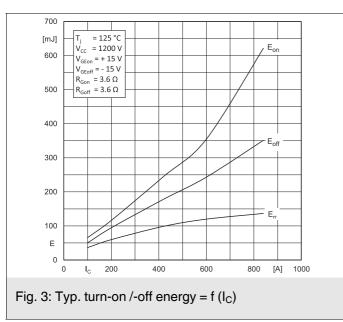
#### Remarks

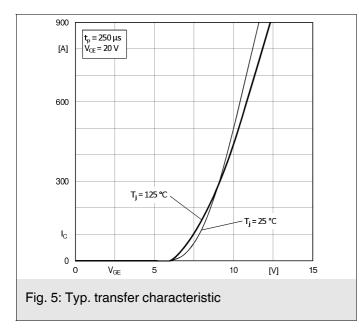
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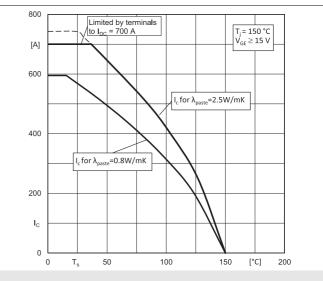
Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverse -	Diode					
$V_F = V_{EC}$	I <sub>F</sub> = 420 A	T <sub>j</sub> = 25 °C		1.66	1.86	V
	chiplevel	T <sub>j</sub> = 125 °C		1.65	1.85	V
V <sub>F0</sub>	chiployol	T <sub>j</sub> = 25 °C		1.10	1.30	V
Chi	- chiplevel	T <sub>j</sub> = 125 °C		0.90	1.10	V
r <sub>F</sub> chiplevel	chiplevel	T <sub>j</sub> = 25 °C		1.33	1.33	mΩ
	chipievei	T <sub>j</sub> = 125 °C		1.78	1.78	mΩ
I <sub>RRM</sub>	di/dt <sub>off</sub> = 5990 A/µs V <sub>GE</sub> = +15/-15 V	T <sub>j</sub> = 125 °C		500		Α
Q <sub>rr</sub>		T <sub>j</sub> = 125 °C		140		μC
E <sub>rr</sub>		T <sub>j</sub> = 125 °C		99		mJ
R <sub>th(j-s)</sub>	per Diode, $\lambda_{paste}$ =0.8 W/(mK)			0.169		K/W
R <sub>th(j-s)</sub>	per Diode, $\lambda_{paste}$ =2.5 W/(mK)			0.125		K/W
Module						
L <sub>CE</sub>				10	15	nH
$R_{CC'+EE'}$	measured per switch	T <sub>s</sub> = 25 °C		0.3		mΩ
		T <sub>s</sub> = 125 °C		0.5		mΩ
w				1042		g
Temperat	ure Sensor					
R <sub>100</sub>	$T_{Sensor} = 100 \ ^{\circ}C \ (R_{25} = 5 \ k\Omega)$			339		Ω
B <sub>100/125</sub>	$R_{(T)} = R_{100} exp[B_{100/125}(1/T-1/373)];$ T[K];			4096		к

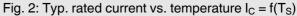


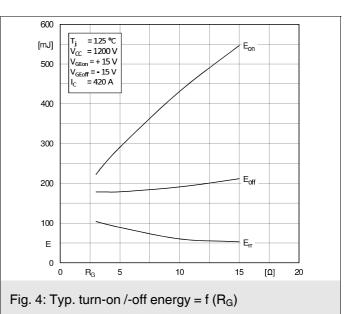


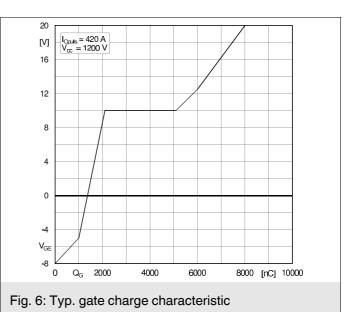


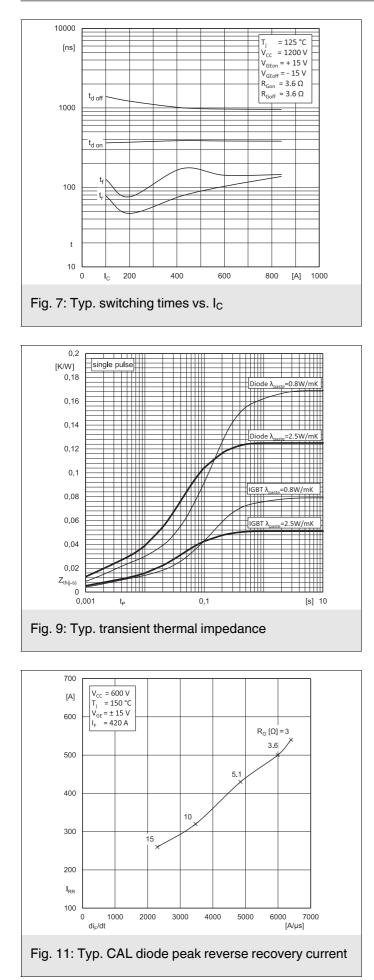












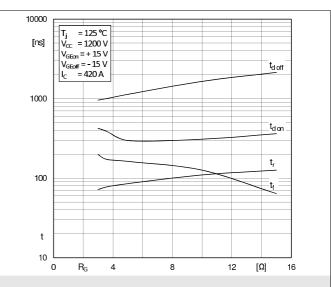
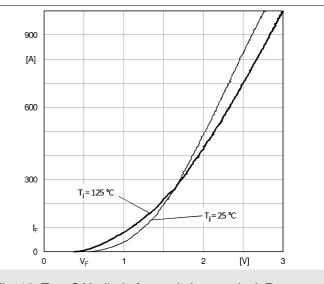
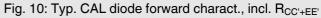
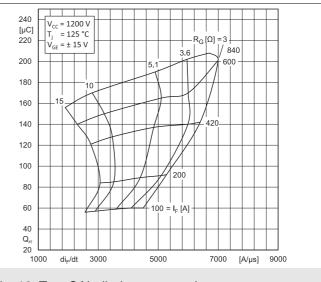
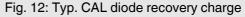


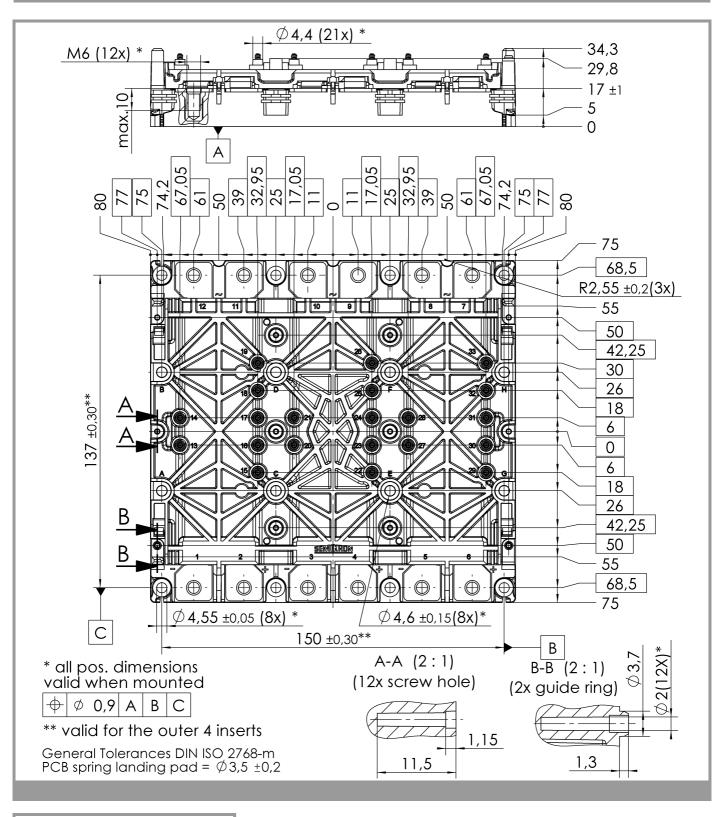
Fig. 8: Typ. switching times vs. gate resistor R<sub>G</sub>

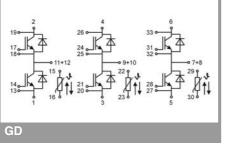












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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